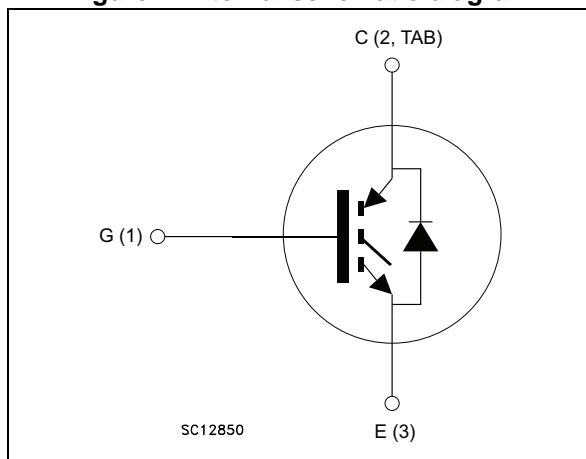


**Figure 1. Internal schematic diagram**



## Features

- Maximum junction temperature:  $T_J = 175 \text{ }^{\circ}\text{C}$
- High speed switching series
- Minimized tail current
- $V_{CE(\text{sat})} = 1.55 \text{ V (typ.)} @ I_C = 30 \text{ A}$
- Tight parameters distribution
- Safe paralleling
- Low thermal resistance
- Very fast soft recovery antiparallel diode

## Applications

- Photovoltaic inverters
- High frequency converters

## Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. These devices are part of the new HB series of IGBTs, which represent an optimum compromise between conduction and switching loss to maximize the efficiency of any frequency converter. Furthermore, the slightly positive  $V_{CE(\text{sat})}$  temperature coefficient and very tight parameter distribution result in safer paralleling operation.

**Table 1. Device summary**

Order code	Marking	Package	Packaging
STGW30H60DFB	GW30H60DFB	TO-247	Tube
STGWT30H60DFB	GWT30H60DFB	TO-3P	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ )	600	V
$I_C$	Continuous collector current at $T_C = 25^\circ\text{C}$	60	A
$I_C$	Continuous collector current at $T_C = 100^\circ\text{C}$	30	A
$I_{CP}^{(1)}$	Pulsed collector current	120	A
$I_F$	Continuous forward current at $T_C = 25^\circ\text{C}$	60	A
$I_F$	Continuous forward current at $T_C = 100^\circ\text{C}$	30	A
$I_{FP}^{(1)}$	Pulsed forward current	120	A
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	260	W
$T_{STG}$	Storage temperature range	- 55 to 150	$^\circ\text{C}$
$T_J$	Operating junction temperature range	- 55 to 175	$^\circ\text{C}$

1. Pulse width limited by maximum junction temperature.

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case IGBT	0.58	$^\circ\text{C}/\text{W}$
$R_{thJC}$	Thermal resistance junction-case diode	2.08	$^\circ\text{C}/\text{W}$
$R_{thJA}$	Thermal resistance junction-ambient	50	$^\circ\text{C}/\text{W}$

## 2 Electrical characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified.

Table 4. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage ( $V_{GE} = 0$ )	$I_C = 2 \text{ mA}$	600			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 30 \text{ A}$		1.55	2	V
		$V_{GE} = 15 \text{ V}, I_C = 30 \text{ A}$ $T_J = 125^\circ\text{C}$		1.65		
		$V_{GE} = 15 \text{ V}, I_C = 30 \text{ A}$ $T_J = 175^\circ\text{C}$		1.75		
$V_F$	Forward on-voltage	$I_F = 30 \text{ A}$		2	2.6	V
		$I_F = 30 \text{ A}; T_J = 125^\circ\text{C}$		1.7		
		$I_F = 30 \text{ A}; T_J = 175^\circ\text{C}$		1.6		
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 1 \text{ mA}$	5	6	7	V
$I_{CES}$	Collector cut-off current ( $V_{GE} = 0$ )	$V_{CE} = 600 \text{ V}$			25	$\mu\text{A}$
$I_{GES}$	Gate-emitter leakage current ( $V_{CE} = 0$ )	$V_{GE} = \pm 20 \text{ V}$			$\pm 250$	nA

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GE} = 0$	-	3659	-	pF
$C_{oes}$	Output capacitance		-	101	-	pF
$C_{res}$	Reverse transfer capacitance		-	76	-	pF
$Q_g$	Total gate charge	$V_{CC} = 520 \text{ V}, I_C = 30 \text{ A}, V_{GE} = 15 \text{ V}$ , see <a href="#">Figure 29</a>	-	149	-	nC
$Q_{ge}$	Gate-emitter charge		-	25	-	nC
$Q_{gc}$	Gate-collector charge		-	62	-	nC

**Table 6. Switching characteristics (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400 \text{ V}, I_C = 30 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ see <a href="#">Figure 28</a>	-	37	-	ns
$t_r$	Current rise time		-	14.6	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	1643	-	A/ $\mu\text{s}$
$t_{d(off)}$	Turn-off delay time		-	146	-	ns
$t_f$	Current fall time		-	23	-	ns
$E_{on}^{(1)}$	Turn-on switching energy		-	383	-	$\mu\text{J}$
$E_{off}^{(2)}$	Turn-off switching energy		-	293	-	$\mu\text{J}$
$E_{ts}$	Total switching energy		-	676	-	$\mu\text{J}$
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400 \text{ V}, I_C = 30 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V}, T_J = 175 \text{ }^\circ\text{C}$ , see <a href="#">Figure 28</a>	-	35	-	ns
$t_r$	Current rise time		-	16.1	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	1496	-	A/ $\mu\text{s}$
$t_{d(off)}$	Turn-off delay time		-	158	-	ns
$t_f$	Current fall time		-	65	-	ns
$E_{on}^{(1)}$	Turn-on switching energy		-	794	-	$\mu\text{J}$
$E_{off}^{(2)}$	Turn-off switching energy		-	572	-	$\mu\text{J}$
$E_{ts}$	Total switching energy		-	1366	-	$\mu\text{J}$

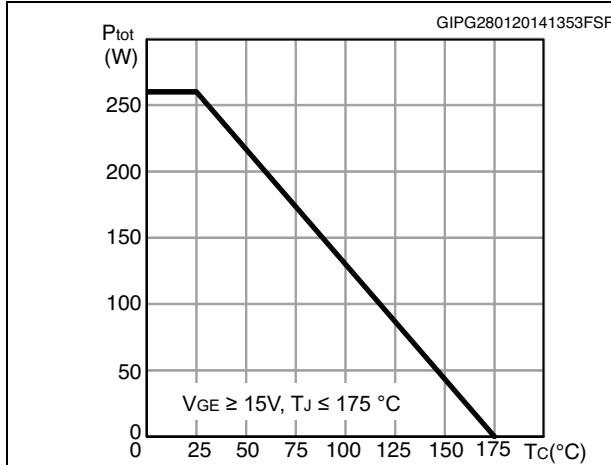
1. Including the reverse recovery of the diode.
2. Including the tail of the collector current.

**Table 7. Diode switching characteristics (inductive load)**

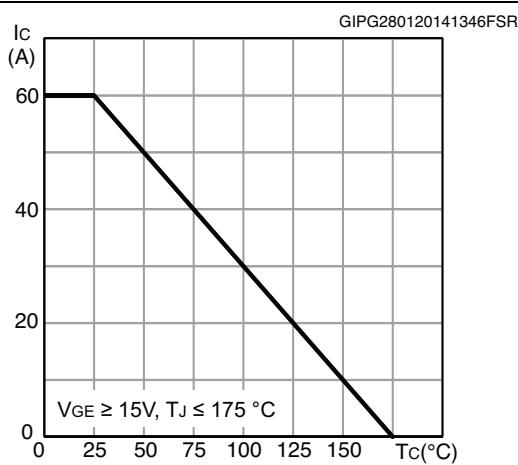
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{rr}$	Reverse recovery time	$I_F = 30 \text{ A}, V_R = 400 \text{ V},$ $di/dt=1000 \text{ A}/\mu\text{s},$ $V_{GE} = 15 \text{ V},$ (see <a href="#">Figure 28</a> )	-	53	-	ns
$Q_{rr}$	Reverse recovery charge		-	384	-	nC
$I_{rrm}$	Reverse recovery current		-	14.5	-	A
$dI_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	788	-	A/ $\mu\text{s}$
$E_{rr}$	Reverse recovery energy		-	104	-	$\mu\text{J}$
$t_{rr}$	Reverse recovery time	$I_F = 30 \text{ A}, V_R = 400 \text{ V},$ $di/dt=1000 \text{ A}/\mu\text{s},$ $V_{GE} = 15 \text{ V},$ $T_J = 175 \text{ }^\circ\text{C}$ , (see <a href="#">Figure 28</a> )	-	104	-	ns
$Q_{rr}$	Reverse recovery charge		-	1352	-	nC
$I_{rrm}$	Reverse recovery current		-	26	-	A
$dI_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	310	-	A/ $\mu\text{s}$
$E_{rr}$	Reverse recovery energy		-	407	-	$\mu\text{J}$

## 2.1 Electrical characteristics (curve)

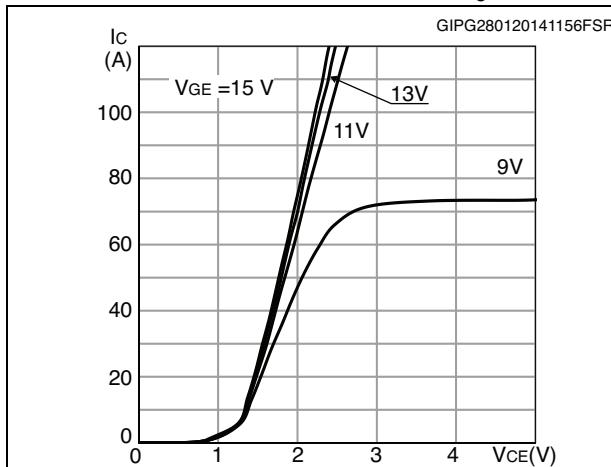
**Figure 2. Power dissipation vs. case temperature**



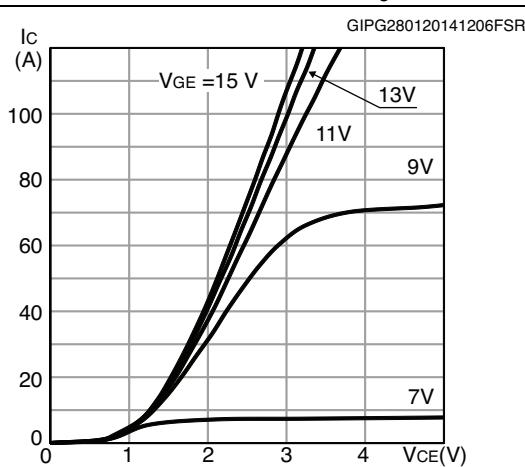
**Figure 3. Collector current vs. case temperature**



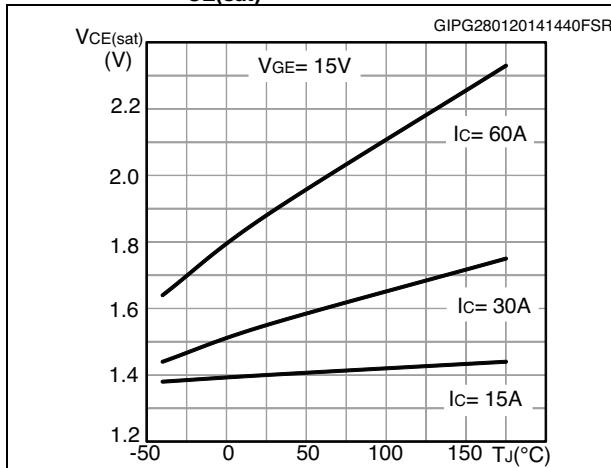
**Figure 4. Output characteristics ( $T_J = 25^{\circ}C$ )**



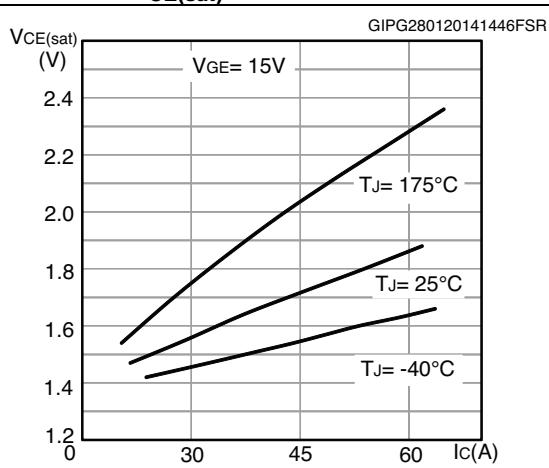
**Figure 5. Output characteristics ( $T_J = 175^{\circ}C$ )**

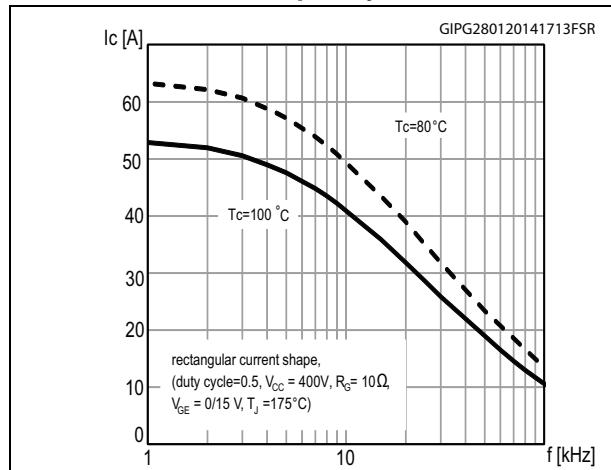
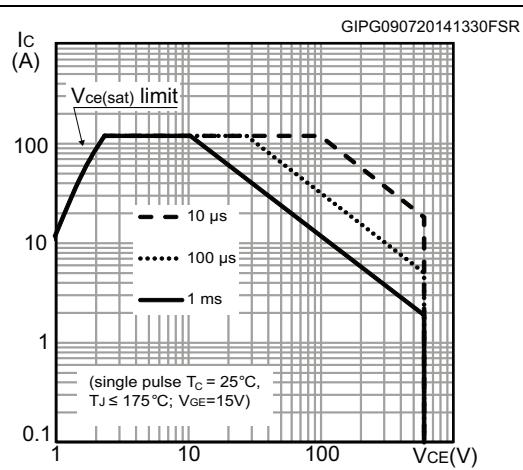
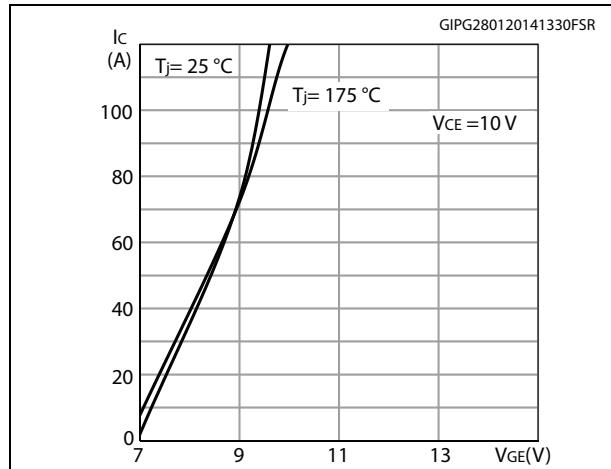
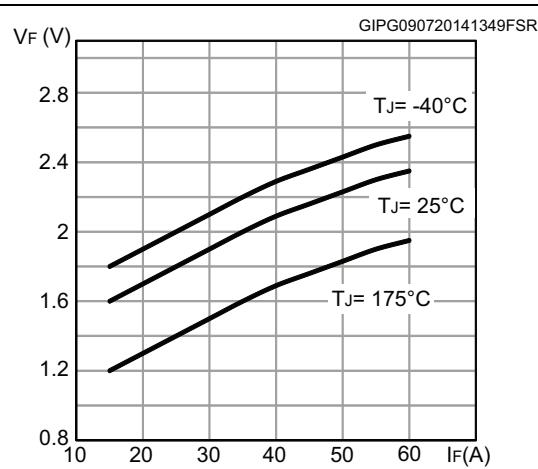
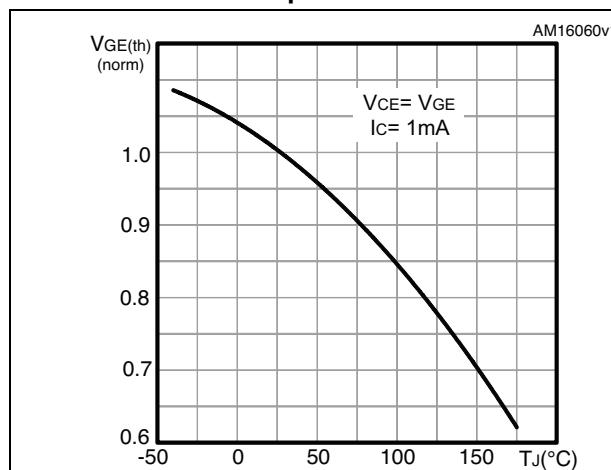
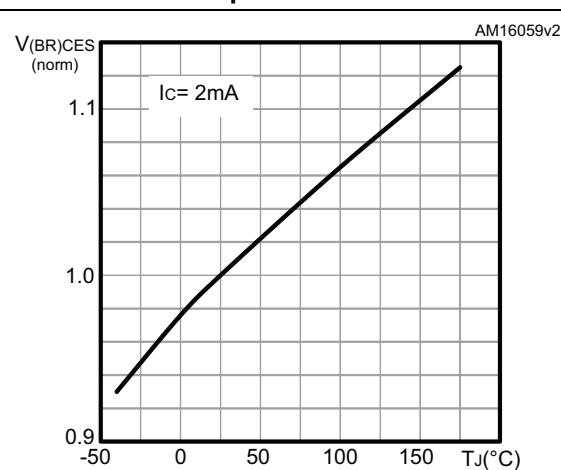


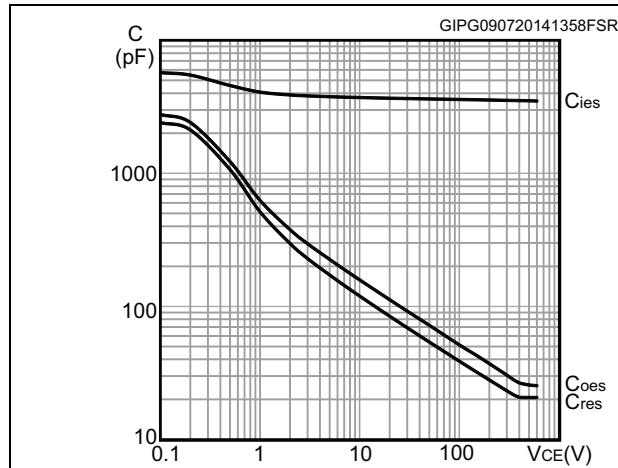
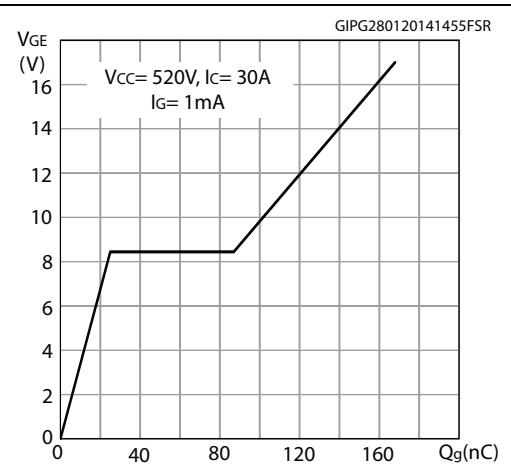
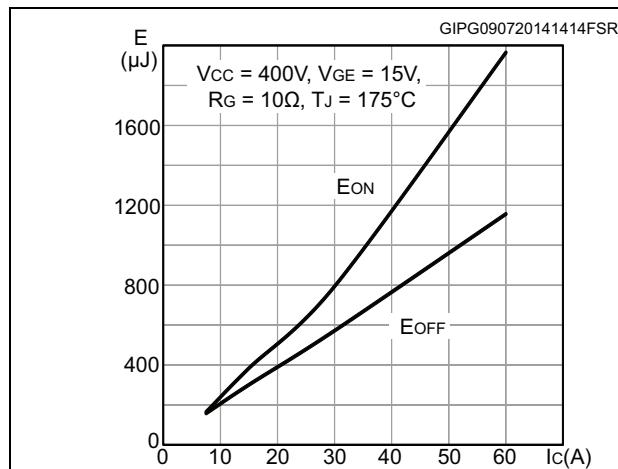
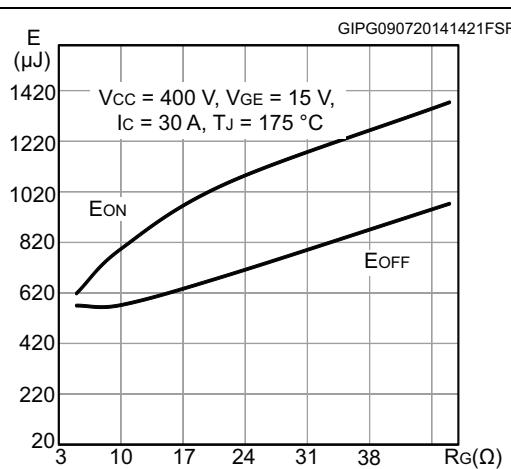
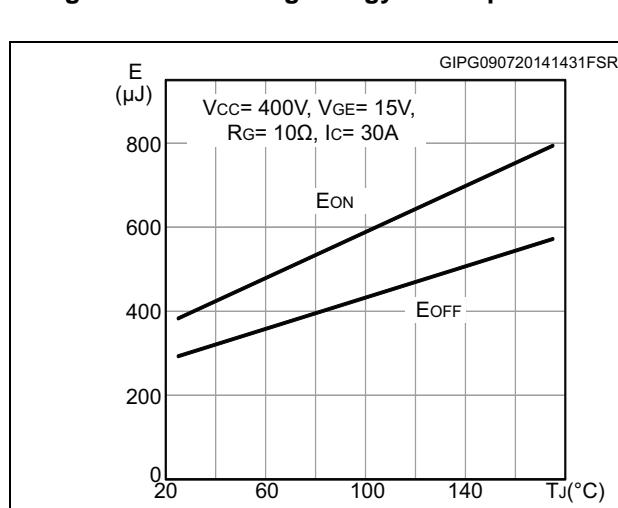
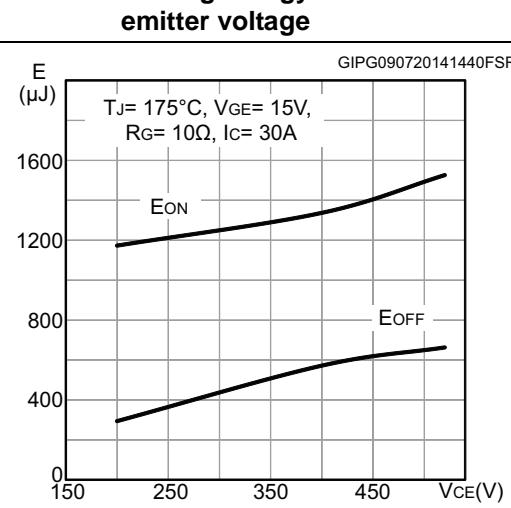
**Figure 6.  $V_{CE(sat)}$  vs. junction temperature**



**Figure 7.  $V_{CE(sat)}$  vs. collector current**



**Figure 8. Collector current vs. switching frequency****Figure 9. Forward bias safe operating area****Figure 10. Transfer characteristics****Figure 11. Diode  $V_F$  vs. forward current****Figure 12. Normalized  $V_{GE(\text{th})}$  vs junction temperature****Figure 13. Normalized  $V_{(BR)CES}$  vs. junction temperature**

**Figure 14. Capacitance variation****Figure 15. Gate charge vs. gate-emitter voltage****Figure 16. Switching energy vs collector current****Figure 17. Switching energy vs gate resistance****Figure 18. Switching energy vs temperature****Figure 19. Switching energy vs collector-emitter voltage**

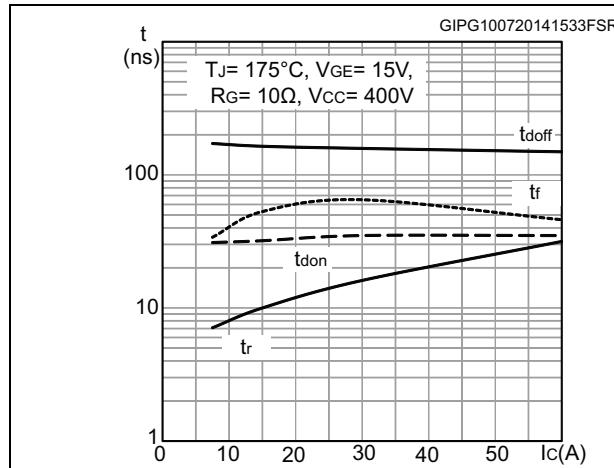
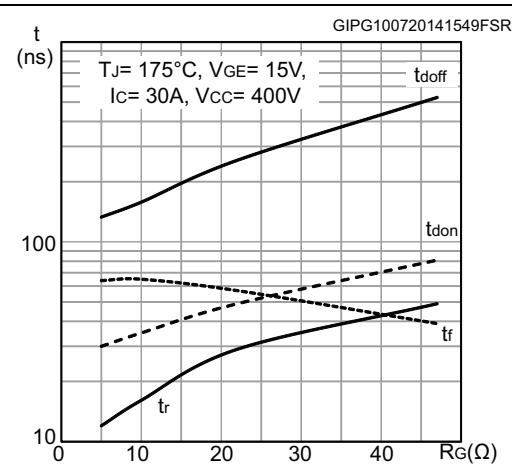
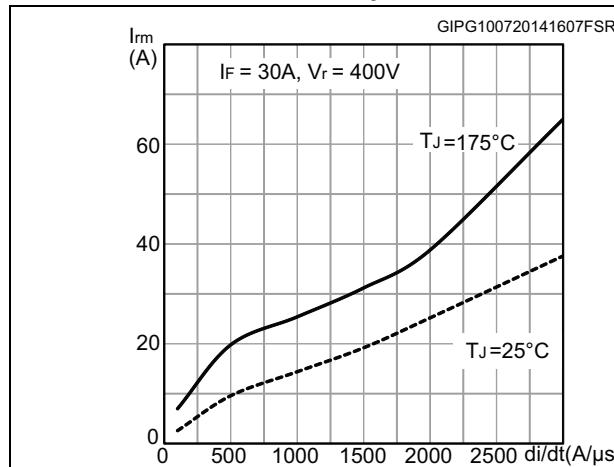
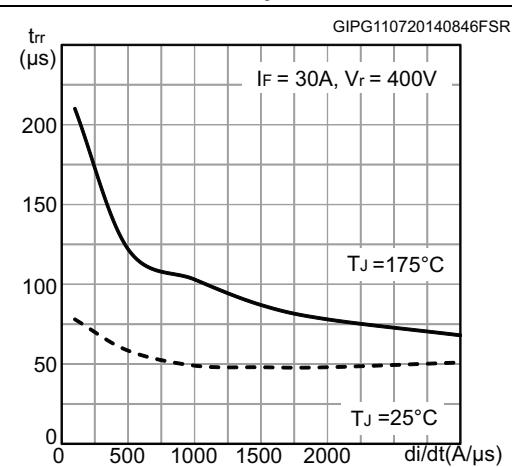
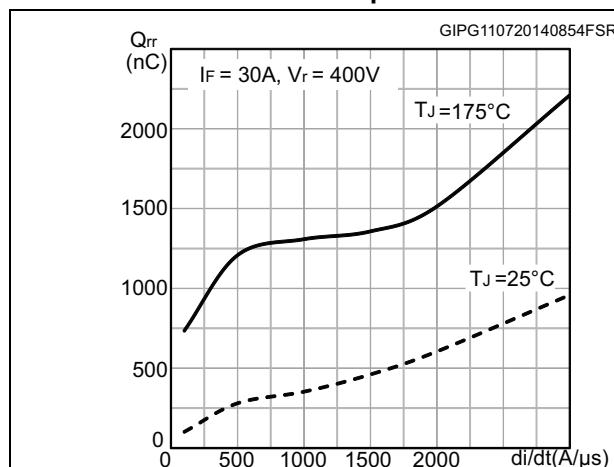
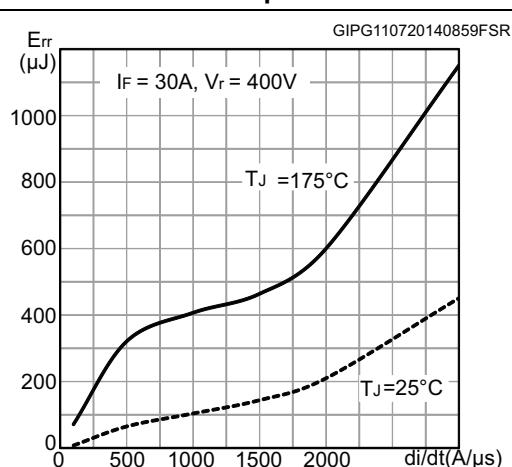
**Figure 20. Switching times vs. collector current****Figure 21. Switching times vs. gate resistance****Figure 22. Reverse recovery current vs. diode current slope****Figure 23. Reverse recovery time vs. diode current slope****Figure 24. Reverse recovery charge vs. diode current slope****Figure 25. Reverse recovery energy vs. diode current slope**

Figure 26. Thermal impedance for IGBT

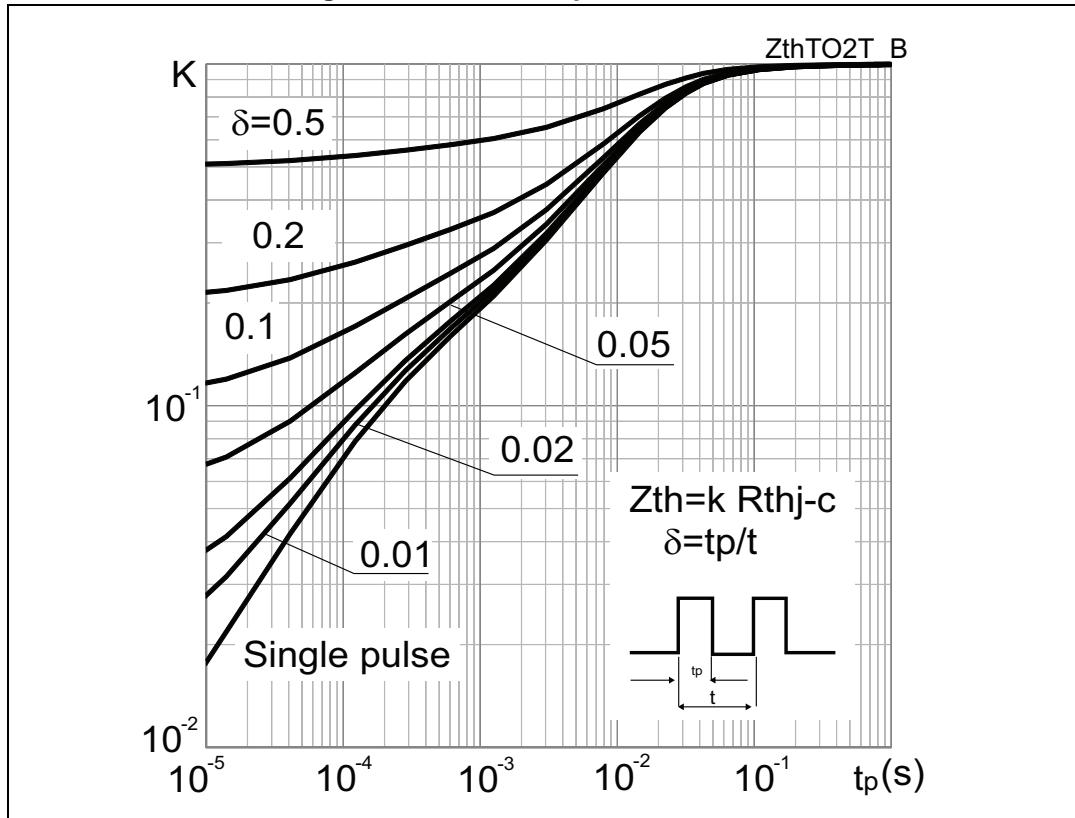
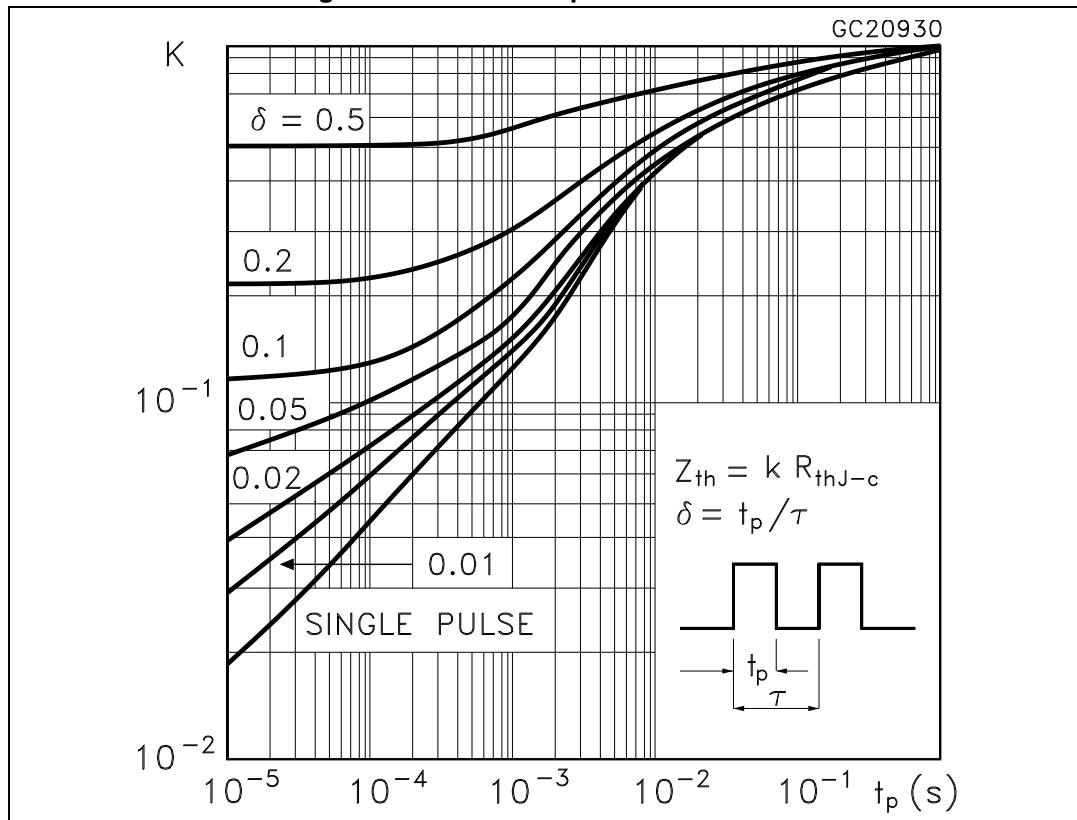
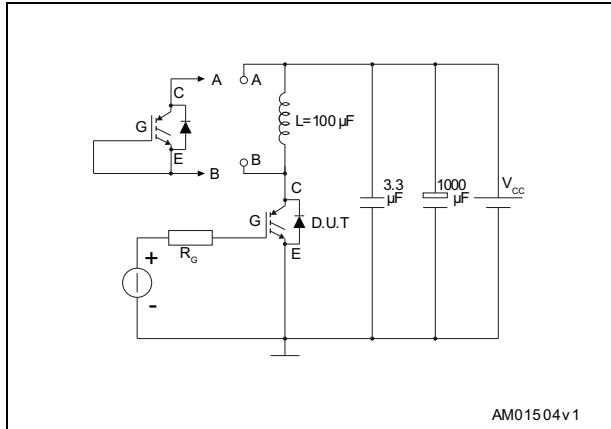


Figure 27. Thermal impedance for diode

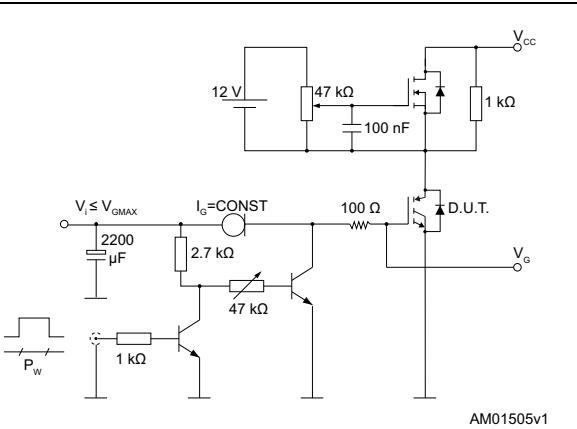


### 3 Test circuits

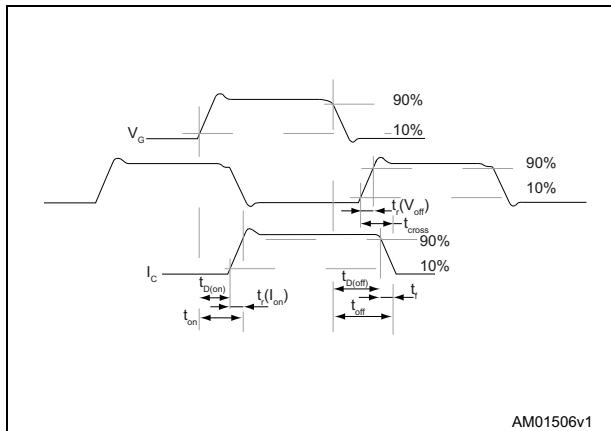
**Figure 28. Test circuit for inductive load switching**



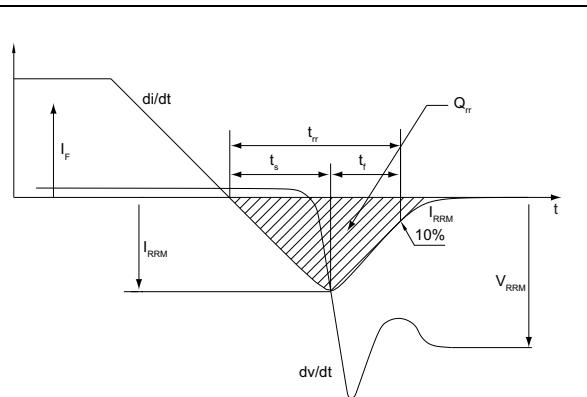
**Figure 29. Gate charge test circuit**



**Figure 30. Switching waveform**



**Figure 31. Diode reverse recovery waveform**

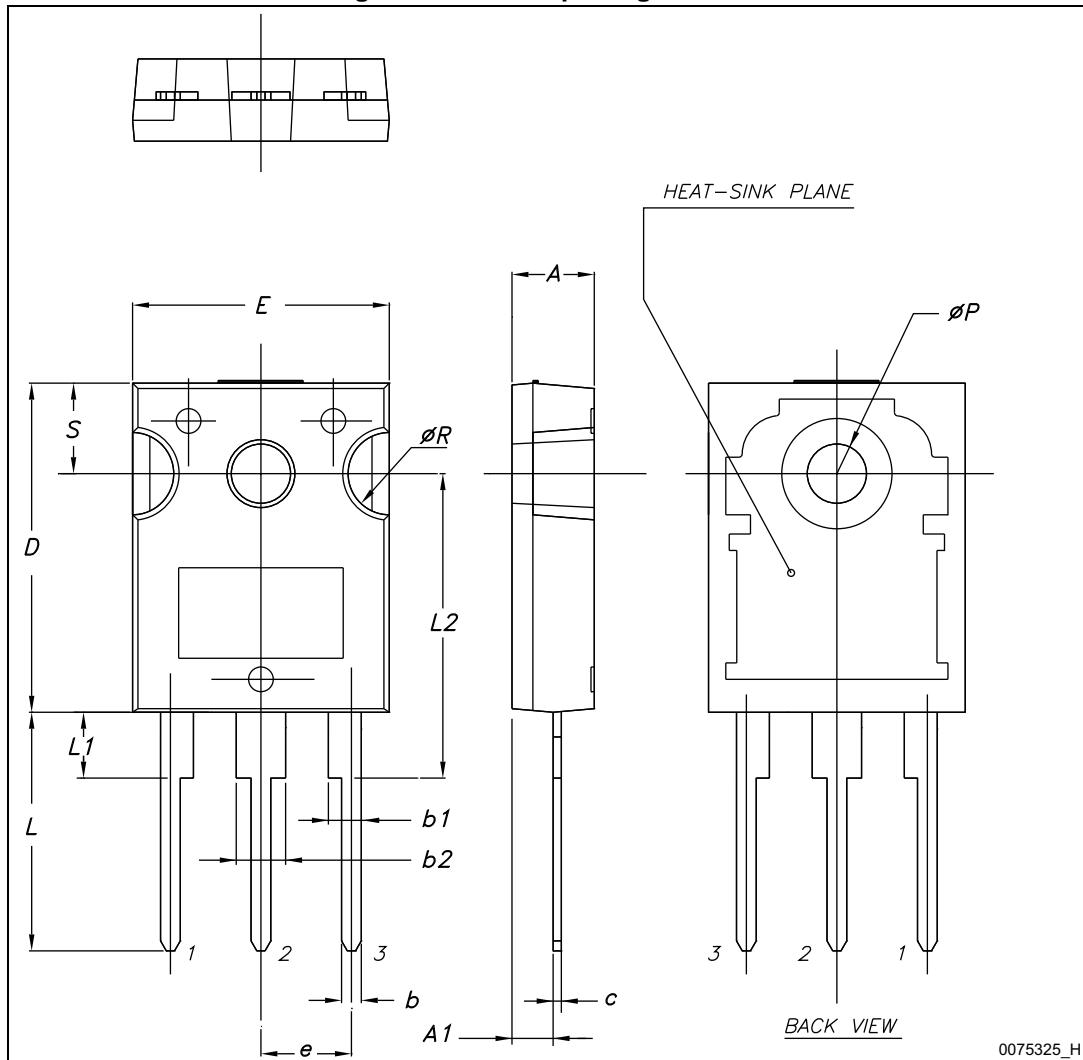


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
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### 4.1 TO-247, STGW30H60DFB

Figure 32. TO-247 package outline

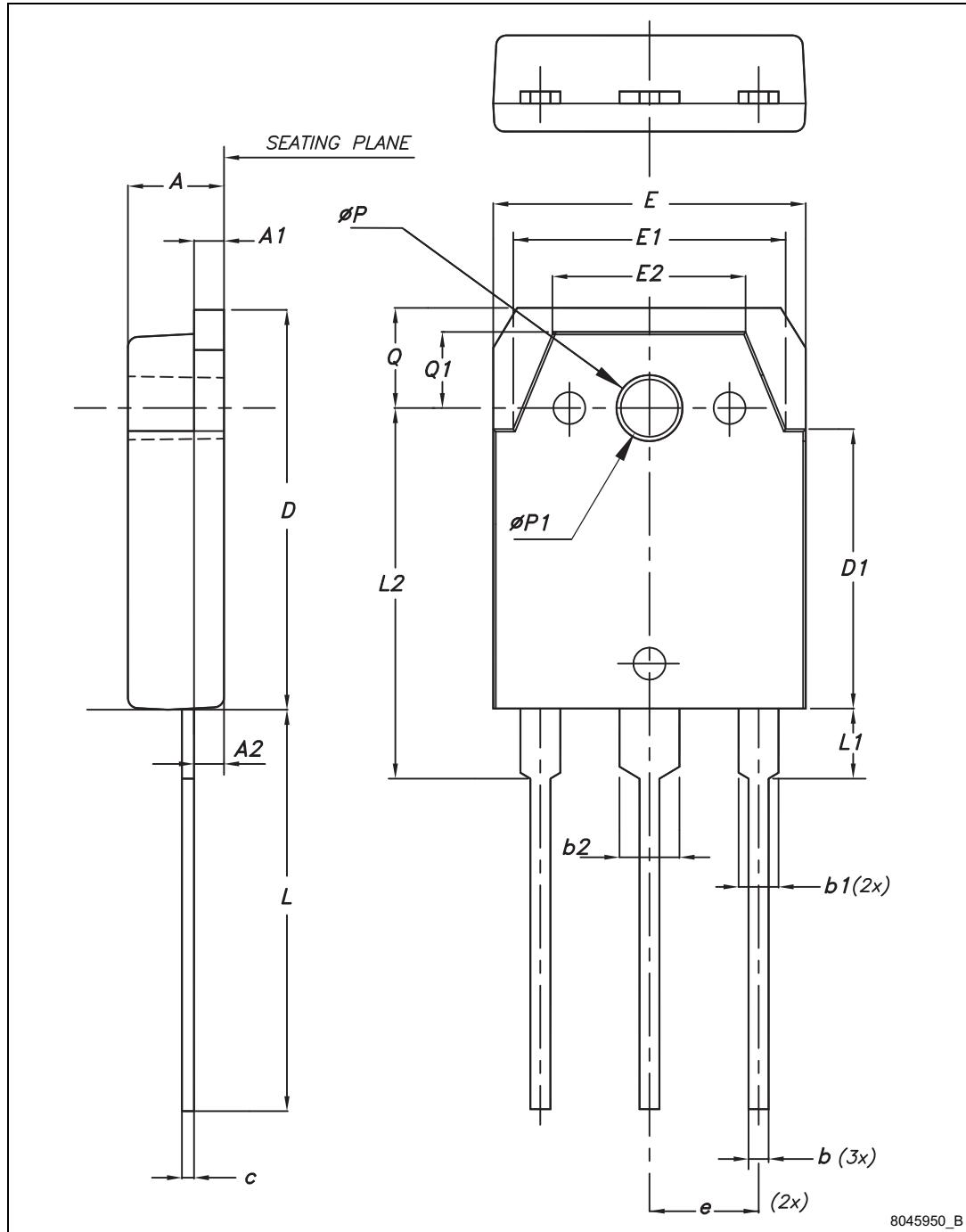


**Table 8. TO-247 package mechanical data**

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

## 4.2 TO-3P, STGWT30H60DFB

Figure 33. TO-3P drawing



**Table 9. TO-3P mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.60	4.80	5
A1	1.45	1.50	1.65
A2	1.20	1.40	1.60
b	0.80	1.00	1.20
b1	1.80	2.00	2.20
b2	2.80	3.00	3.20
c	0.55	0.60	0.75
D	19.70	19.90	20.10
D1	13.70	13.90	14.10
E	15.40	15.60	15.80
E1	13.40	13.60	13.80
E2	9.40	9.60	9.90
e	5.15	5.45	5.75
L	19.80	20	20.20
L1	3.30	3.50	3.70
L2	18.20	18.40	18.60
øP	3.30	3.40	3.50
øP1	3.10	3.20	3.30
Q	4.80	5	5.20
Q1	3.60	3.80	4

## 5 Revision history

**Table 10. Document revision history**

Date	Revision	Changes
01-Aug-2014	1	Initial release.
17-Feb-2016	2	Modified: <i>Table 2, Table 4</i> and 6 Modified: <i>Figure 16</i> Updated: <i>Section 3</i> Updated: <i>Section 4.1: TO-247, STGW30H60DFB</i> Minor text changes

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